Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/776,610	HABE ET AL.	
Examiner	Art Unit	
Brian S. Kwon	1614	

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Class	Subclass	Date	Examiner
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INI	INTERFERENCE SEARCHED				
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
STN, EAST, NPL	10/13/2006	вк
Continuity Data, Inventor Name Search		
Ref: 10/776610, 10/197403, 10/224923, 10/139724, 10/135397, 09/881799, 10/019110		V
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